

**Search Notes**

Application/Control No.

10/661,454

Examiner

John P. Leubecker

Applicant(s)/Patent under  
Reexamination

PHAN, HUY D.

Art Unit

3739

**SEARCHED**

Class	Subclass	Date	Examiner
600	104- 106,128- 130,114,1 60,182	5/31/2005	JPL
600	153	5/31/2005	JPL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East Text Search	5/31/2005	JPL